



IFW

IBM Docket No. FIS920030333US1

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of: **Christopher P. Ausschnitt et al.**

Serial No.: **10/716,927**

Date: **April 22, 2005**

Filed: **November 19, 2003**

Group Art Unit: **2877**

Examiner: **Gordon J. Stock, Jr.**

Title: **OVERLAY TARGET AND MEASUREMENT METHOD USING
REFERENCE AND SUB-GRIDS**

DeLIO & PETERSON, LLC
121 Whitney Avenue
New Haven, CT 06510-1241

LETTER TO OFFICIAL DRAFTSMAN

Mail Stop ISSUE FEE

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Dear Sir:

Applicants are herewith submitting **12** sheets of Formal Drawings for the approval of the Draftsman.

Please charge the Assignee IBM Corporation Deposit Account No. **09-0458** for any fee related to the acceptance of the attached Formal Drawings. A duplicate copy of this letter is enclosed for that purpose.

Respectfully submitted,

BY:

Attorney: **Peter W. Peterson**

Registration No. **31,867**

(203) 787-0595

ibmf100410000offdrftltr